

Issue Classification				Application No.		Applicant(s)	
				10/045,237		KIM, JONG-SUN	
				Examiner		Art Unit	
				Hai L. Nguyen		2816	

ORIGINAL				CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
327	158	327	161	175	244		
INTERNATIONAL CLASSIFICATION							
H	0	3	L	7/06	/	/	/
Hai L. Nguyen (Assistant Examiner)		01/13/2005 (Date)		TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner)		Total Claims Allowed: 27 O.G. Print Claim(s) 1	
<i>[Signature]</i> (Legal Instruments Examiner)		1/24/05 (Date)		<i>[Signature]</i> (Date)		O.G. Print Fig. 5	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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4	4		34		64		94
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6	8		38		68		98
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10	10		40		70		100
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12	12		42		72		102
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22	22		52		82		112
23	23		53		83		113
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26	26		56		86		116
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	28		58		88		118
	29		59		89		119
	30		60		90		120